

# STC CR02AM Sensitive Gate Silicon Controlled Rectifier

# **Reverse Blocking Thyristor**

PNPN device designed for line-powered general purpose applications such as relay and lamp drivers, small motor controls, gate drivers for larger thyristors, and sensing and detection circuits. Supplied in a cost effective plastic TO-92 package.

- Sensitive Gate Allows Direct Triggering by Microcontrollers and Other Logic Circuits
- On-State Current Rating of 0.8 Amperes RMS at 80°C
- Surge Current Capability 10 Amperes
- Immunity to dV/dt 20 V/µsec Minimum at 110°C
- Glass-Passivated Surface for Reliability and Uniformity
- Blocking Voltage to 600 Volts

#### **MAXIMUM RATINGS** (T<sub>J</sub> = 25°C unless otherwise noted)

Rating	Symbol	Value	Unit
Peak Repetitive Off–State Voltage (Note 1.) (T <sub>J</sub> = -40 to 110°C, Sine Wave, 50 to 60 Hz; Gate Open)	V <sub>DRM,</sub> V <sub>RRM</sub>	600	Volts
On-State RMS Current (T <sub>C</sub> = 80°C) 180° Conduction Angles	I <sub>T(RMS)</sub>	0.8	Amp
Peak Non-Repetitive Surge Current (1/2 Cycle, Sine Wave, 60 Hz, T <sub>J</sub> = 25°C)	I <sub>TSM</sub>	10	Amps
Circuit Fusing Consideration (t = 10 ms)	l <sup>2</sup> t	0.415	A <sup>2</sup> s
Forward Peak Gate Power $(T_A = 25^{\circ}C, \text{ Pulse Width } \leq 1.0 \mu\text{s})$	P <sub>GM</sub>	0.1	Watt
Forward Average Gate Power (T <sub>A</sub> = 25°C, t = 20 ms)	P <sub>G(AV)</sub>	0.10	Watt
Forward Peak Gate Current $(T_A = 25^{\circ}C, \text{ Pulse Width } \leq 1.0 \mu\text{s})$	I <sub>GM</sub>	1.0	Amp
Reverse Peak Gate Voltage $(T_A = 25^{\circ}C, \text{ Pulse Width } \leq 1.0 \mu\text{s})$	$V_{GRM}$	5.0	Volts
Operating Junction Temperature Range  @ Rate V <sub>RRM</sub> and V <sub>DRM</sub>	TJ	-40 to 110	°C
Storage Temperature Range	T <sub>stg</sub>	–40 to 150	°C

(1) VDRM and VRRM for all types can be applied on a continuous basis. Ratings apply for zero or negative gate voltage; however, positive gate voltage shall not be applied concurrent with negative potential on the anode. Blocking voltages shall not be tested with a constant source such that the voltage ratings of the devices are exceeded.

# SCR 0.8 AMPERES RMS 600 VOLTS





TO-92 (TO-226) CASE 029 STYLE 10

PIN ASSIGNMENT		
1	Cathode	
2	Anode	
3	Gate	

## CR02AM

#### THERMAL CHARACTERISTICS

Characteristic	Symbol	Max	Unit
Thermal Resistance – Junction to Case – Junction to Ambient	$R_{ hetaJC} \ R_{ hetaJA}$	75 200	°C/W
Lead Solder Temperature (<1/16" from case, 10 secs max)	T <sub>L</sub>	260	°C

#### **ELECTRICAL CHARACTERISTICS** (T<sub>C</sub> = 25°C unless otherwise noted)

ELECTRICAL CHARACTERISTICS (1C = 25°C un	less offierwise floted	)				
Characteristic		Symbol	Min	Тур	Max	Unit
OFF CHARACTERISTICS			-		-	-
Peak Repetitive Forward or Reverse Blocking Current (Note 1.) $(V_D = Rated\ V_{DRM}\ and\ V_{RRM};\ R_{GK} = 1.0\ kΩ)$	$T_{C} = 25^{\circ}C$ $T_{C} = 110^{\circ}C$	I <sub>DRM</sub> , I <sub>RRM</sub>		_ _	10 0.1	μA mA
ON CHARACTERISTICS				_	_	_
Peak Forward On–State Voltage <sup>(*)</sup> (I <sub>TM</sub> = 1.0 Amp Peak @ T <sub>A</sub> = 25°C)		$V_{TM}$	-	-	1.7	Volts
Gate Trigger Current (Continuous dc) (Note 2.) (V <sub>AK</sub> = 12 V, R <sub>L</sub> = 100 Ohms)	T <sub>C</sub> = 25°C	I <sub>GT</sub>	_	6	8	μА
Holding Current (Note 2.) (V <sub>AK</sub> = 12 V, I <sub>GT</sub> = 0.5 mA)	$T_C = 25^{\circ}C$ $T_C = -40^{\circ}C$	lн	-  -	0.5 -	5.0 10	mA
Latch Current $(V_{AK} = 12 \text{ V}, I_{GT} = 0.5 \text{ mA}, R_{GK} = 1.0 \text{ k})$	$T_C = 25^{\circ}C$ $T_C = -40^{\circ}C$	ΙL	-  -	0.6 -	10 15	mA
Gate Trigger Voltage (Continuous dc) (Note 2.) (V <sub>AK</sub> = 12 V, R <sub>L</sub> = 100 Ohms, I <sub>GT</sub> = 10 mA)	$T_C = 25^{\circ}C$ $T_C = -40^{\circ}C$	V <sub>GT</sub>	_ _	0.62 -	0.8 1.2	Volts
DYNAMIC CHARACTERISTICS			-		-	-
Critical Rate of Rise of Off–State Voltage ( $V_D$ = Rated $V_{DRM}$ , Exponential Waveform, $R_{GK}$ = 11 $T_J$ = 110°C)	000 Ohms,	dV/dt	20	35	-	V/µs
Critical Rate of Rise of On–State Current (I <sub>PK</sub> = 20 A; Pw = 10 µsec; diG/dt = 1.0 A/µsec, Igt = 20 mA)		di/dt	_	_	50	A/μs

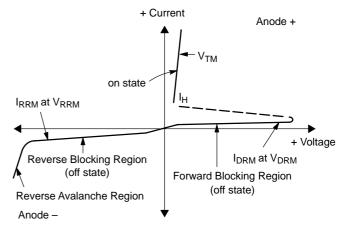
<sup>\*</sup>Indicates Pulse Test: Pulse Width ≤ 1.0 ms, Duty Cycle ≤ 1%.

 $<sup>\</sup>begin{array}{ll} \hbox{1.} & R_{GK} = 1000 \mbox{ Ohms included in measurement.} \\ \hbox{2.} & \mbox{Does not include } R_{GK} \mbox{ in measurement.} \\ \end{array}$ 

#### CR02AM

## **Voltage Current Characteristic of SCR**

Symbol	Parameter
V <sub>DRM</sub>	Peak Repetitive Off State Forward Voltage
I <sub>DRM</sub>	Peak Forward Blocking Current
$V_{RRM}$	Peak Repetitive Off State Reverse Voltage
I <sub>RRM</sub>	Peak Reverse Blocking Current
V <sub>TM</sub>	Peak on State Voltage
I <sub>H</sub>	Holding Current



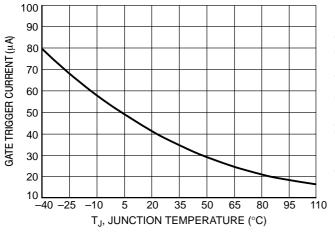


Figure 1. Typical Gate Trigger Current versus Junction Temperature

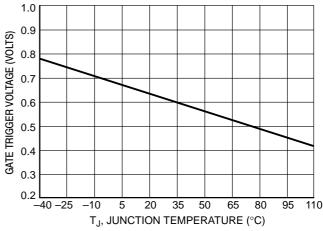


Figure 2. Typical Gate Trigger Voltage versus Junction Temperature

## CR02AM

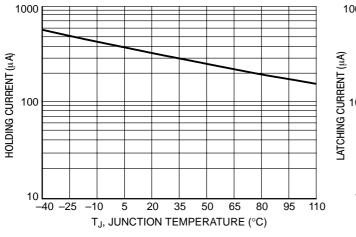


Figure 3. Typical Holding Current versus Junction Temperature

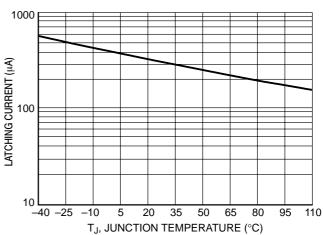


Figure 4. Typical Latching Current versus Junction Temperature

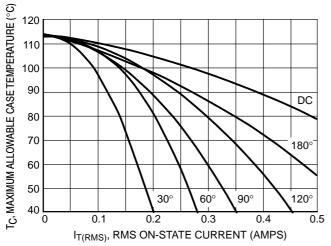


Figure 5. Typical RMS Current Derating

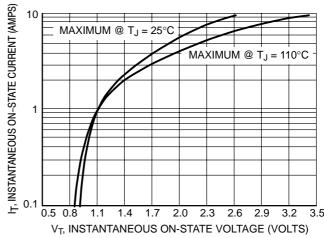


Figure 6. Typical On-State Characteristics